

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/624,774	LUETKEMEYER, CHRISTIAN	
		Examiner	Art Unit	Page 1 of 1
		Stephen M. Baker	2133	

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4,748,626	05-1988	Wong, Chin-Pan	714/746
	B	US-4,823,346	04-1989	Kobayashi et al.	714/794
	C	US-5,379,306	01-1995	Noma et al.	714/792
	D	US-5,410,555	04-1995	Itakura et al.	714/795
	E	US-5,457,705	10-1995	Todoroki, Toshiya	714/795
	F	US-5,509,021	04-1996	Todoroki, Toshiya	714/795
	G	US-5,651,032	07-1997	Okita, Shigeru	375/341
	H	US-5,717,706	02-1998	Ikeda, Tamotsu	714/786
	I	US-5,841,819	11-1998	Hu et al.	375/341
	J	US-5,946,361	08-1999	Araki et al.	375/341
	K	US-6,205,187	03-2001	Westfall, Dan L.	375/341
	L	US-6,289,487	09-2001	Hessel et al.	714/795
	M	US-6,598,205	07-2003	Luetkemeyer, Christian	714/795

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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